



12500 TI Boulevard, MS 8640, Dallas, Texas 75243

**PCN#20141119000**  
**Qualification of Alternate Assembly/Test Sites for Selected devices in the TSSOP**  
**Package**  
**Change Notification / Sample Request**

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The changes discussed within this PCN will not take effect any earlier than **90** days from the date of this notification, unless customer agreement has been reached on an earlier implementation of the change. This notification period is per TI's standard process.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager ([PCN\\_ww\\_admin\\_team@list.ti.com](mailto:PCN_ww_admin_team@list.ti.com)).

Sincerely,

PCN Team  
SC Business Services  
Phone: +1(214) 480-6037  
Fax: +1(214) 480-6659

**PCN# 20141119000**  
**Attachment: 1**

**Products Affected:**

According to our records, there are the affected device(s) that you have purchased within the past twenty-four (24) months. Technical details of this Product Change follow on the next page(s).

<b>PCN Number:</b>	20141119000	<b>PCN Date:</b>	12/03/2014
<b>Title:</b>	Qualification of ASE Shanghai as an alternate Assembly/Test Site for Selected devices in the TSSOP Package		
<b>Customer Contact:</b>	<a href="#">PCN Manager</a>	<b>Phone:</b>	+1(214)480-6037
<b>Dept:</b>	Quality Services		
<b>Proposed 1<sup>st</sup> Ship Date:</b>	03/03/2015	<b>Estimated Sample Availability:</b>	Provided upon Request
<b>Change Type:</b>			
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process
<input checked="" type="checkbox"/>	Design	<input type="checkbox"/>	Electrical Specification
<input checked="" type="checkbox"/>	Test Site	<input type="checkbox"/>	Mechanical Specification
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Packing/Shipping/Labeling
<input type="checkbox"/>	Wafer Fab Site	<input type="checkbox"/>	Test Process
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Material
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Process
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Materials
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Process
<input type="checkbox"/>		<input type="checkbox"/>	Part number change

### PCN Details

#### Description of Change:

Texas Instruments is pleased to announce the qualification of ASE Shanghai (ASES) as an alternate Assembly and Test site for the devices listed below in Group 1 and TI Taiwan (TAI) as an additional Assembly site for the devices in Group 2. Group 2 devices will have identical BOMs between the 2 sites. For group 1, BOM differences are noted in the table below:

What	MLA	AP1	ASESH
Mold Compound	4206193	SID# 101325962	<b>SID#EN2000508</b>
Mound Compound	4042500	SID#101306338	<b>SID#EY1000063</b>

Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ.

#### Reason for Change:

Continuity of Supply

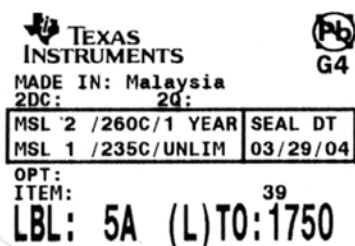
#### Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

None

#### Changes to product identification resulting from this PCN:

Assembly Site		
Amkor Philippines	Assembly Site Origin (22L)	ASO: AKR
TI Malaysia	Assembly Site Origin (22L)	ASO: MLA
<b>TI Taiwan</b>	<b>Assembly Site Origin (22L)</b>	<b>ASO: TAI</b>
<b>ASE Shanghai</b>	<b>Assembly Site Origin (22L)</b>	<b>ASO: ASH</b>

Sample product shipping label (not actual product label)



(1P) SN74LS07NSR  
 (Q) 2000 (D) 0336  
 (31T) LOT: 3959047MLA  
 (4W) TKY (1T) 7523483SI2  
 (P)  
 (2P) REV: (V) 0033317  
 (20L) CSO: SHE (21L) CCO:USA  
 (22L) ASO: MLA (23L) ACO: MYS

**Topside Device marking:**

Assembly site code for AKR= 4

Assembly site code for MLA= K

**Assembly site code for TAI= T**

**Assembly site code for ASH= A**

**Product Affected**

**Qualification Group #1 Devices (ASESH assembly):**

AM26C31PWR	MAX3232IPWR	SN74HC125PWR	SN74HC32PWR
CD4066BPWR	SN74ACT08PWR	SN74HC138PWR	SN74HC595PWR
CD4069UBPWR	SN74AHCT125PWR	SN74HC14PWR	SN74HCT04PWR
CD4541BPWR	SN74HC00PWR	SN74HC164PWR	SN74HCT138PWR
CD74HC123PWR	SN74HC02PWR	SN74HC166PWR	SN74HCT14PWR
LM239PWR	SN74HC04PWR	SN74HC174PWR	SN74HCT32PWR
LM339APWR	SN74HC05PWR	SN74HC259PWR	SN74HCU04PWR
MAX232ECPWR	SN74HC08PWR		

**Qualification Group #2 Devices (TAI assembly):**

DRV8833PWP	DRV8833PWR
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**Qualification Group #1 Data:**

**Qualification Report**

**MAX232ECPWR Qual (ASESH 14 and 16 pins TSSOP Offload)**

Approved 09/22/2014

**Product Attributes**

Attributes	Qual Device: MAX232ECPWR	QBS Package: RC4558PWR	QBS Package: SN74LV14APWR	QBS Package: SN74LVC14APWR	QBS Package: ULN2003APW	QBS Package: LMV324IPWR	QBS Package: SN74AHC595PWR	QBS Package: SN74CBT13306PWR	QBS Package: SN74CBTLV3245APWR
Assembly Site	ASESH	ASE SHANGHAI	ASESH	ASE-SH	ASESH	ASE SHANGHAI	ASE SHANGHAI	ASE SHANGHAI	ASE SHANGHAI
Package Family	TSSOP	TSSOP	TSSOP	TSSOP	TSSOP	TSSOP	TSSOP	TSSOP	TSSOP
Flammability Rating	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0
Wafer Fab Supplier	DFAB	SFAB	SFAB	FFAB	SFAB	FFAB	SFAB	SFAB	FFAB
Wafer Fab Process	LBC3S	JI-SLM	EPIC1-S_SLM	P-9760 TLM	JI-SLM	BCB	EPIC1S DLM	50C24X2	ASL3C

- QBS: Qual By Similarity  
 - Qual Device MAX232ECPWR is qualified at LEVEL1-260C

**Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	QBS Package: RC4558PWR	QBS Package: SN74LV14APWR	QBS Package: SN74LVC14APWR	QBS Package: ULN2003APW	QBS Package: LMV324IPWR	QBS Package: SN74AHC595PWR	QBS Package: SN74CBT13306PWR	QBS Package: SN74CBTLV3245APWR
HAST	Biased HAST, 130C/85%RH	96 Hours	1/77/0	1/77/0	1/77/0	1/77/0	2/158/0	1/77/0	1/77/0	1/77/0
THB	Temperature Humidity Bias 85C/85%RH	1000 Cycles	-	-	-	-	-	-	-	-
AC	Autoclave 121C	96 Hours	-	-	-	-	-	-	-	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0
TC	Temperature Cycle, -65/150C	500 Cycles	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0	1/77/0
HTSL	High Temp. Storage Bake 170C	420 Hours	-	-	-	-	1/77/0	1/77/0	1/77/0	1/77/0
HTSL	High Temp. Storage Bake 150C	1000 Hours	1/77/0	1/77/0	1/77/0	1/77/0	-	-	-	-
HTOL	Life Test, 150C	300 hours	1/77/0	1/77/0	1/77/0	1/77/0	2/164/0	1/77/0	1/77/0	1/77/0
WBS	Ball Bond Shear	Wires	-	-	-	-	-	-	-	-
WBP	Bond Pull	Wires	-	-	-	-	-	-	-	-
PD	Physical Dimensions	--	-	-	-	-	-	-	-	-
HBM	ESD - HBM	1000 V	-	-	-	-	-	-	-	-
CDM	ESD - CDM	250 V	-	-	-	-	-	-	-	-
LU	CMOS Latchup	(per JESD78 class II)	-	-	-	-	-	-	-	-
ED	Electrical Characterization	Per Datasheet Parameters	Pass	Pass	Pass	Pass	Pass	Pass	Pass	Pass
	Bond Strength	Wires	1/76/0	1/76/0	1/76/0	1/76/0	2/160/0	1/77/0	1/77/0	1/77/0

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable  
 - The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours  
 - The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours  
 - The following are equivalent Temp Cycle options per JESD47 : -65C/125C/700 Cycles and -65C/150C/500 Cycles  
 Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>  
**Green/Pb-free Status:**  
 Qualified Pb-Free(SMT) and Green

**Qualification Group #2 Data:**

<b>Reference Qualification Data: Approved April 2012</b>			
This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.			
<b>Qualification Device: DRV8812A1PWP (MSL1-260C)</b>			
<b>Package Construction Details</b>			
Assembly Site:	TAI A/T	Mold Compound:	4205443
# Pins-Designator, Family:	28-PWP, TSSOP	Mount Compound:	4208458
Lead Frame Material/Finish:	Cu, NiPdAu	Bond Wire:	1.3 Mil Dia., Cu
<b>Qualification:</b> <input type="checkbox"/> <b>Plan</b> <input checked="" type="checkbox"/> <b>Test Results</b>			
Reliability Test	Conditions	Sample Size / Fail	
Electrical Characterization	Per Datasheet Limits	Pass	
**Autoclave 121C	121C, 2 atm (96 Hrs)	77/0	
**T/C -65C/150C	-65C/+150C (500 Cyc)	77/0	
ESD HBM	500V, 1000V, 1500V	3/0	
ESD CDM	200V, 500V	3/0	
Latch-up	(per JESD78)	6/0	
Notes: **Tests require preconditioning sequence: MSL1-260C			

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

<b>Location</b>	<b>E-Mail</b>
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
Japan	<a href="mailto:PCNJapanContact@list.ti.com">PCNJapanContact@list.ti.com</a>